

October 2013

### FCH47N60F F085

# N-Channel MOSFET 600V, 47A, 75m $\Omega$

#### **Features**

- Typ  $r_{DS(on)}$  = 66m $\Omega$  at  $V_{GS}$  = 10V,  $I_D$  = 47A
- Typ  $Q_{q(tot)}$  = 190nC at  $V_{GS}$  = 10V,  $I_D$  = 47A
- UIS Capability
- RoHS Compliant
- Qualified to AEC Q101

### **Description**

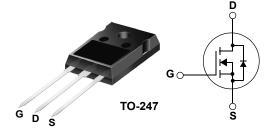
SuperFET<sup>TM</sup> is Fairchild's proprietary new generation of high voltage MOSFETs utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance.

This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy.

Consequently, SuperFET is suitable for various automotive DC/DC power conversion.

### **Applications**

- Automotive On Board Charger
- Automotive DC/DC converter for HEV



For current package drawing, please refer to the Fairchild website at www.fairchildsemi.com/packaging



### **MOSFET Maximum Ratings** $T_J = 25^{\circ}C$ unless otherwise noted

| Symbol                            | Parameter                                                 |                       | Ratings      | Units |
|-----------------------------------|-----------------------------------------------------------|-----------------------|--------------|-------|
| V <sub>DSS</sub>                  | Drain to Source Voltage                                   |                       | 600          | V     |
| V <sub>GS</sub>                   | Gate to Source Voltage                                    |                       | ±30          | V     |
|                                   | Drain Current - Continuous (V <sub>GS</sub> =10) (Note 1) | T <sub>C</sub> = 25°C | 47           | ^     |
| ID                                | Pulsed Drain Current                                      | T <sub>C</sub> = 25°C | See Figure4  | Α     |
| E <sub>AS</sub>                   | Single Pulse Avalanche Energy                             | (Note 2)              | 810          | mJ    |
| Ъ                                 | Power Dissipation                                         |                       | 417          | W     |
| $P_D$                             | Derate above 25°C                                         |                       | 3.3          | W/°C  |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Temperature                         |                       | -55 to + 150 | °C    |
| $R_{\theta JC}$                   | Thermal Resistance Junction to Case                       |                       | 0.3          | °C/W  |
| $R_{\theta JA}$                   | Maximum Thermal Resistance Junction to Ambient            | (Note 3)              | 50           | °C/W  |

### **Package Marking and Ordering Information**

| Device Marking | Device         | Package | Reel Size | Tape Width | Quantity |
|----------------|----------------|---------|-----------|------------|----------|
| FCH47N60F      | FCH47N60F_F085 | TO-247  | -         | -          | 30 units |

#### Notes:

- 1: Current is limited by bondwire configuration.
- 2: Starting  $T_J = 25^{\circ}C$ , L = 5mH,  $I_{AS} = 18A$ ,  $V_{DD} = 100V$  during inductor charging and  $V_{DD} = 0V$  during time in avalanche
- 3:  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design. The maximum rating presented here is based on mounting on a 1 in<sup>2</sup> pad of 2oz copper.

Units

Max

### **Electrical Characteristics** $T_J = 25^{\circ}C$ unless otherwise noted

**Parameter** 

| Off Characteristics |                                                  |                           |                                 |     |   |      |    |
|---------------------|--------------------------------------------------|---------------------------|---------------------------------|-----|---|------|----|
| B <sub>VDSS</sub>   | Drain to Source Breakdown Voltage                | I <sub>D</sub> = 250μA, \ | / <sub>GS</sub> = 0V            | 600 | - | -    | V  |
|                     | I <sub>DSS</sub> Drain to Source Leakage Current | V <sub>DS</sub> =600V,    | $T_{\rm J} = 25^{\rm o}{\rm C}$ | -   | - | 10   | μА |
| DSS                 |                                                  | $V_{GS} = 0V$             | $T_J = 150^{\circ} C(Note 4)$   | -   | - | 1    | mA |
| $I_{GSS}$           | Gate to Source Leakage Current                   | $V_{GS} = \pm 30V$        |                                 | -   | - | ±100 | nA |

**Test Conditions** 

Min

Тур

### **On Characteristics**

Symbol

| $V_{GS(th)}$            | Gate to Source Threshold Voltage     | $V_{GS} = V_{DS}, I_D = 250 \mu A$ |                              | 3.0 | 4.0 | 5.0 | V         |
|-------------------------|--------------------------------------|------------------------------------|------------------------------|-----|-----|-----|-----------|
| r Drain to Source On Bo | Drain to Source On Resistance        | I <sub>D</sub> = 47A,              | $T_{J} = 25^{\circ}C$        | -   | 66  | 75  | $m\Omega$ |
| r <sub>DS(on)</sub>     | DS(on) Drain to Source On Resistance | V <sub>GS</sub> = 10V              | $T_J = 150^{\circ}C(Note 4)$ | -   | 180 | 223 | mΩ        |

### **Dynamic Characteristics**

| C <sub>iss</sub> | Input Capacitance             | V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V,<br>f = 1MHz |                        | - | 5900 | 8000 | pF |
|------------------|-------------------------------|----------------------------------------------------------|------------------------|---|------|------|----|
| C <sub>oss</sub> | Output Capacitance            |                                                          |                        | - | 3200 | 4200 | pF |
| C <sub>rss</sub> | Reverse Transfer Capacitance  |                                                          |                        | - | 250  | -    | pF |
| $R_g$            | Gate Resistance               | f = 1MHz                                                 |                        | - | 1    | -    | Ω  |
| $Q_{g(ToT)}$     | Total Gate Charge at 10V      | $V_{GS} = 0$ to 10V                                      | V <sub>DD</sub> = 300V | - | 190  | 250  | nC |
| $Q_{g(th)}$      | Threshold Gate Charge         | $V_{GS} = 0$ to 2V                                       | I <sub>D</sub> = 47A   | - | 12   | 18   | nC |
| $Q_{gs}$         | Gate to Source Gate Charge    |                                                          |                        | - | 40   | -    | nC |
| $Q_{gd}$         | Gate to Drain "Miller" Charge |                                                          |                        | - | 96   | -    | nC |

### **Switching Characteristics**

| t <sub>on</sub>     | Turn-On Time        |                                               | - | -   | 410  | ns |
|---------------------|---------------------|-----------------------------------------------|---|-----|------|----|
| t <sub>d(on)</sub>  | Turn-On Delay Time  |                                               | - | 110 | -    | ns |
| t <sub>r</sub>      | Rise Time           | V <sub>DD</sub> = 300V, I <sub>D</sub> = 47A, | - | 160 | -    | ns |
| t <sub>d(off)</sub> | Turn-Off Delay Time | $V_{GS}$ = 10V, $R_{G}$ = 25 $\Omega$         | - | 540 | -    | ns |
| t <sub>f</sub>      | Fall Time           |                                               | - | 125 | -    | ns |
| t <sub>off</sub>    | Turn-Off Time       |                                               | - | -   | 1000 | ns |

### **Drain-Source Diode Characteristics**

| \ /             | Causes to Dusin Diada Valtage | I <sub>SD</sub> = 47A, V <sub>GS</sub> = 0V | - | -   | 1.4  | V  |
|-----------------|-------------------------------|---------------------------------------------|---|-----|------|----|
| $V_{SD}$        | Source to Drain Diode Voltage | $I_{SD} = 23.5A, V_{GS} = 0V$               | - | -   | 1.25 | V  |
| T <sub>rr</sub> | Reverse Recovery Time         | $I_F = 47A$ , $dI_{SD}/dt = 100A/\mu s$ ,   | - | 207 | 350  | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge       | V <sub>DD</sub> =480V                       | - | 2.0 | 3.6  | uC |

#### Notes

4: The maximum value is specified by design at  $T_J$  = 150°C. Product is not tested to this condition in production.

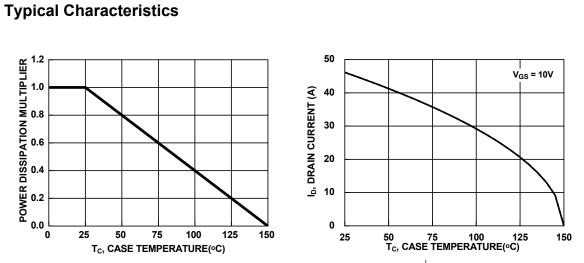


Figure 1. Normalized Power Dissipation vs Case Temperature

Figure 2. Maximum Continuous Drain Current vs Case Temperature

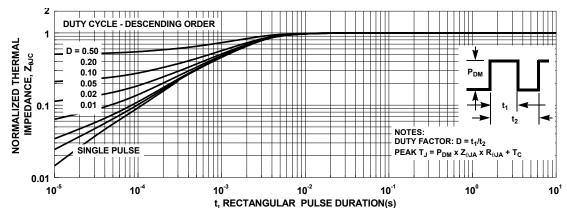


Figure 3. Normalized Maximum Transient Thermal Impedance

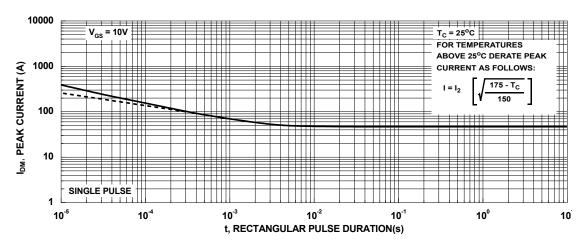
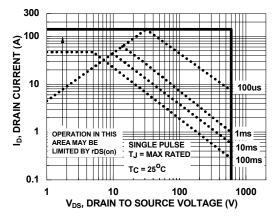


Figure 4. Peak Current Capability

### **Typical Characteristics**



PULSE DURATION = 80 µs
DUTY CYCLE = 0.5% MAX

V<sub>DD</sub> = 20V

T<sub>J</sub> = 150°C

T<sub>J</sub> = -55°C

T<sub>J</sub> = -55°C

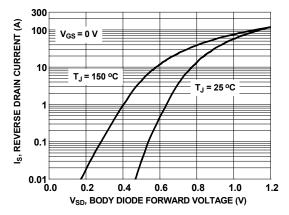
T<sub>J</sub> = -55°C

V<sub>GS</sub>, GATE TO SOURCE VOLTAGE (V)

100

Figure 5. Forward Bias Safe Operating Area

Figure 6. Transfer Characteristics



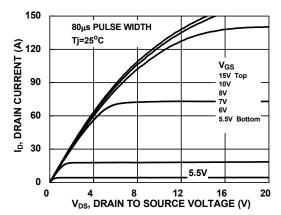
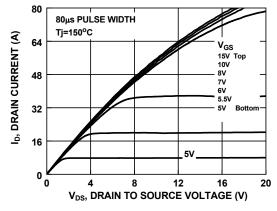


Figure 7. Forward Diode Characteristics

Figure 8. Saturation Characteristics



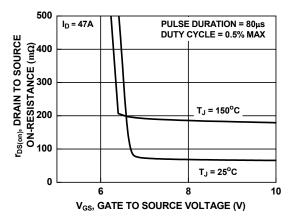


Figure 9. Saturation Characteristics

Figure 10. Rdson vs Gate Voltage

### **Typical Characteristics**

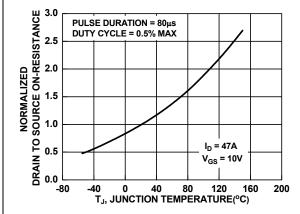


Figure 11. Normalized Rdson vs Junction **Temperature** 

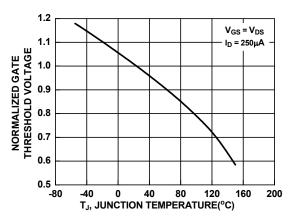


Figure 12. Normalized Gate Threshold Voltage vs **Temperature** 

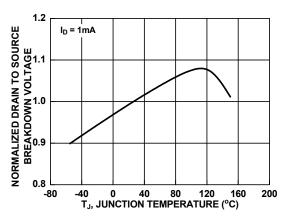


Figure 13. Normalized Drain to Source **Breakdown Voltage vs Junction Temperature** 

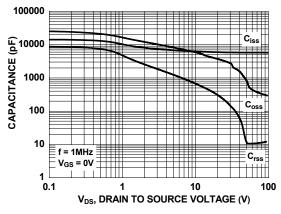


Figure 14. Capacitance vs Drain to Source Voltage Figure 16.

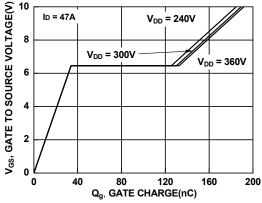


Figure 15. Gate Charge vs Gate to Source Voltage





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